



SHEET 1 OF 1

INFORMATION DISCLOSURE
CITATION IN AN
APPLICATION

(PTO-1449)

ATTY. DOCKET NO.
60188-725SERIAL NO.
10751,525APPLICANT
Mitsuyasu OHTA, et al.FILING DATE
January 06, 2004GROUP
2133

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		US 5,258,985	11/02/1993	Spence et al.	
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						Yes	No
/CB/		EP 0472 818 A2	03/04/1992	INTERNATIONAL BUSINESS MACHINES CORPORATION		X	/

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
/CB/		MO Chin Tsung., et al. " Self Diagnostic BIST Memory Design Scheme." IEEE, pp. 7-9, August 8, 1994
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.

INFORMATION DISCLOSURE CITATION IN AN APPLICATION

(PTO-1449)

 ATTY. DOCKET NO.
60188-725

 SERIAL NO.
Continuation of Appl. N .
09/381,377

 APPLICANT
Mitsuyasu OHTA, et al.

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/CB/		Y. ZORIAN, "Test Requirements for Embedded Core-Based Systems and IEEE P1500", International Test Conference Proceedings, 11/01/1997 - 11/06/1997, pages 191-199.
/CB/		M. ABRAMOVICI, "Design For Testability Techniques: A Comparative Analysis", June 2002, USPTO Lecture.

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